


<b>Search Notes</b>  	<b>Application/Control No.</b>  10563302	<b>Applicant(s)/Patent Under Reexamination</b>  KOBAYASHI ET AL.
	<b>Examiner</b>  Mai, Tien	<b>Art Unit</b>  2836

SEARCHED			
Class	Subclass	Date	Examiner
361	234	11/20/2007	TM
198	619	11/20/2007	TM

SEARCH NOTES		
Search Notes	Date	Examiner
see East search	11/20/2007	TM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner